

10/582227
APR 30 2009 PCT/PTO 09 JUN 2009

PTO/SB/08a/b (07-05)
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INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use as many sheets as necessary)		Application Number	Not Yet Assigned
		Filing Date	Concurrently Herewith
		First Named Inventor	Son Nguyen-Kim
		Art Unit	N/A
		Examiner Name	Not Yet Assigned
Sheet	1	of	1
		Attorney Docket Number	13111-00042-US1

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code ² (if known)			
	AA*	US-4,767,613	08-30-1988	Nuber et al.	
	AB*	US-6,482,393	11-19-2002	Schehlmann et al.	
	AC*	US-5,840,804	11-24-1998	Carl et al.	
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	AG*	US-20050265950-A1	12-01-2005	Christoffels et al.	

FOREIGN PATENT DOCUMENTS							
Examiner Initials*	Cite No. ¹	Foreign Patent Document		Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	†
		Country Code ³ -Number-Kind Code ² (if known)					
	BA	EP-0 183 466		06-04-1986	Kyoritsu Yuki Co Ltd (JP)		
	BB	WO-0039176		07-06-2000	Goodrich Co B F (et al.)		
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	BG	WO-2004058837		07-15-2004	BASF AG et al.		
	BH	WO-2005005497		01-20-2005	BASF AG et al.		

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Examiner Signature	/Vu Nguyen/	Date Considered	12/30/2009
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